Search Notes



Application/Control No.	Applicant(s)/Patent under Reexamination	_
10/092,906	CHEN ET AL.	
Examiner	Art Unit	_
Peter Coughlan	2129	

	SEARCHED				
Class	Subclass	Date	Examiner		
706	1	3/3/2006	PDC		
706	15	3/3/2006	PDC		
706	45	3/3/2006	PDC		
700	1	3/3/2006	PDC		
700	90	3/3/2006	PDC		
375	354	3/3/2006	PDC		
704	256	3/3/2006	PDC		
701	110	3/3/2006	PDC		
713	322	3/3/2006	PDC		
713	501	3/3/2006	PDC		

INT	INTERFERENCE SEARCHED					
Class	Subclass	Date	Examiner			

SEARCH NOTES (INCLUDING SEARCH STRATEGY)				
	DATE	EXMR		
East-neural network, frequency, rate, clock speed, chen, tseng, CPU, vector, radial, change, alter, variable, parameter	3/3/2006	PDC		
EastIIregister, input, clock skew, clock multiplier, ide, pci, dma, gaussian, multiquadric, agp, external frequency	3/3/2006	PDC		
EastIIImakagon.in., monza.in., training,	3/3/2006	PDC		
Inventors I-Larn Chen Yuh-Dar Tseng	3/3/2006	PDC		
IEEE—CPU, changing/altering rates - frequency - clock, tarining ide / clock multiplier / dma / pci / apg, I-Larn Chen, Tseng	3/3/2006	PDC		
375.354 with multiple clocks, 704.256 with training with past and present CPU frequencies	3/3/2006	PDC		
701.110 with training with DMA 713.322 with neural network and changing clock rate	3/3/2006	PDC		
713.501 with clock multiplier factor	3/3/2006	PDC		